SHIGA7.040APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Hayashi et al.

Appl. No.

10/561,830

Filed

: December 22, 2005

For

POSITIVE RESIST

COMPOSITION AND METHOD OF FORMING RESIST PATTERN

USING SAME

Examiner

Thompson Rummel, P.

Group Art Unit

1795

AMENDMENT AND RESPONSE TO OFFICE ACTION

Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed **November 26, 2008**, please consider the following amendments and remarks:

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.